

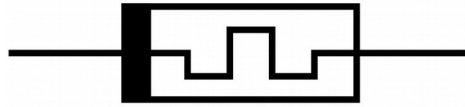
# Modeling Multistability and Hysteresis in Devices

**Tianshi Wang**

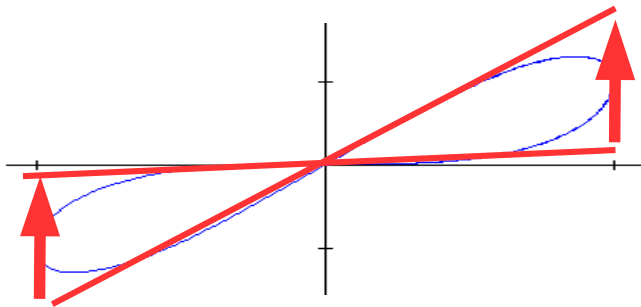
EECS Department, University of California, Berkeley



# Devices with Hysteresis

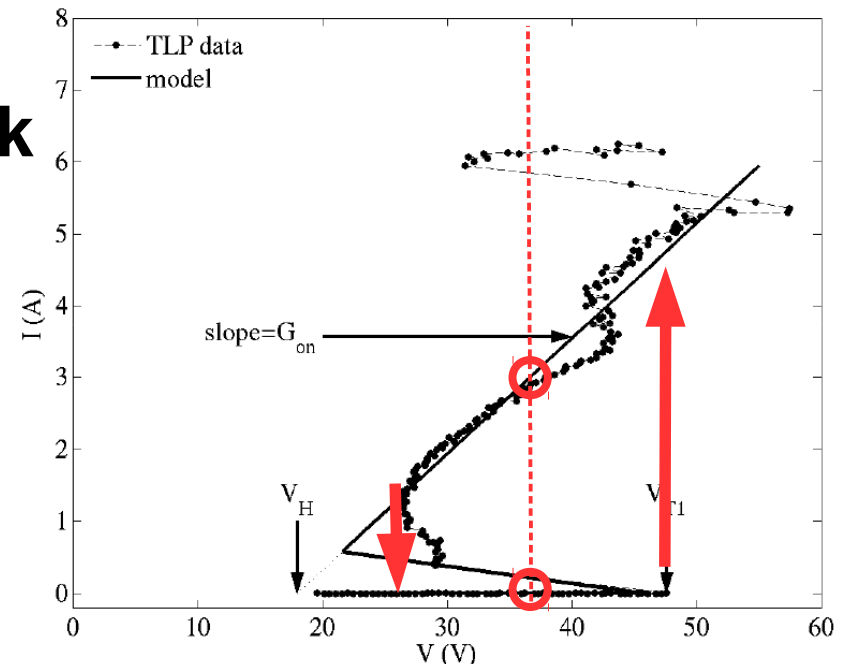


**memristor**  
(RRAM, CBRAM, PCM...)



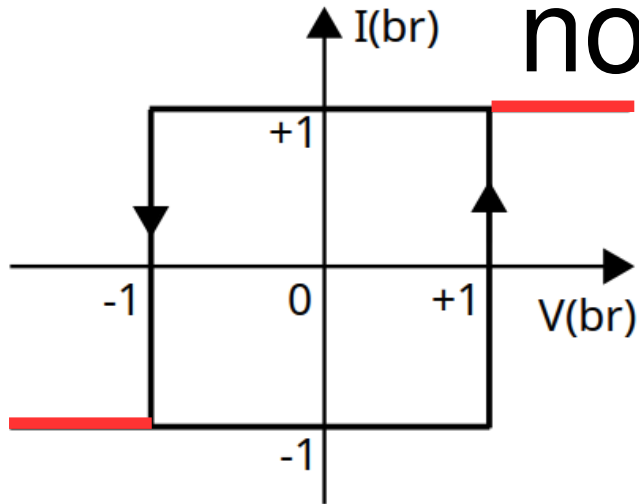
**magnetic core**

## ESD snapback



Ida/McAndrew. "A Physically-based Behavioral Snapback Model." IEEE EOS/ESD Symposium, 2012.

# How to model hysteresis?



not

“memory state”  
“hidden state”

```

1 real i;
2 analog begin
3     if V(br) < -1
4         i = -1;
5     if V(br) > +1
6         i = +1;
7     I(br) <+ i;
8 end
    
```

not an analog  
compact model

Boolean variable  
“hybrid model”

## memristor

(RRAM, CBRAM, PCM...)

- Linear/nonlinear ion drift models  
Biolek (2009), Jogelkar(2009),  
Prodromakis (2011), etc.
- UMich RRAM model (2011)
- TEAM model (2012)
- Simmons tunneling barrier model  
(2013)
- Yakopcic model (2013)
- Stanford/ASU RRAM model (2014)
- Knowm “probabilistic” model (2015)

```

$bound_step(tstep);
c_time = $abstime;
dt = c_time - p_time;
x = x_last + dt * exp(...);
    
```

```

@(initial_step) begin
    x = x_init;
end
    
```

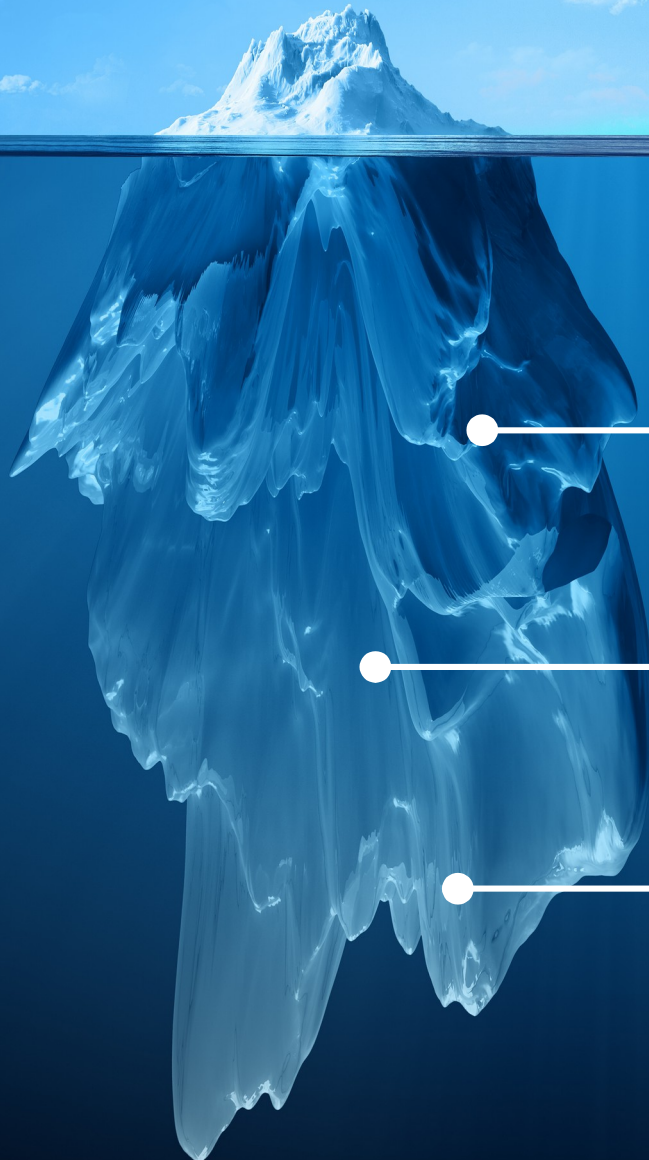
```

1 int isON = 0;
2 if (abs(V(...)) > V_snap)
3     isON = 1;
4 if (isON) {
5     ...
6 } else {
7     ...
8 }
    
```

only for TRAN  
none works for DC, AC, PSS

# Verilog-A problems

**DC failures**



**problematic physics**

**poor understanding of VA**

**ill-posed models**

# Good Compact Models

- “simulation-ready”

- run in all analyses (DC, AC, TRAN, sensitivity, shooting, HB, ...)

- run in all simulators

**consistently**

~~analysis-specific code~~

- a simple (trivial) example

```
...  
I(p, n) <+ V(p, n)/R;  
I(p, n) <+ ddt(C * V(p, n));  
...
```

- differential equation format

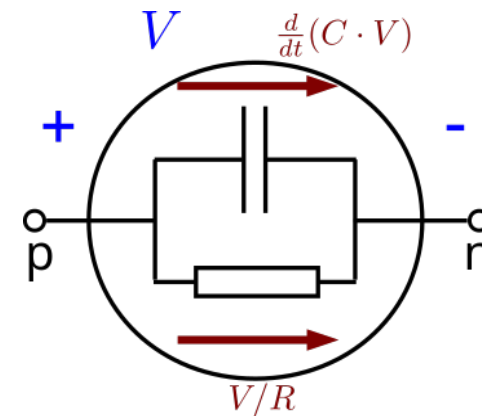
$$ipn = \frac{d}{dt}q(vpn) + f(vpn)$$

“charges” and “currents”, continuous and smooth

- no \$abstime, idt(), @initial\_step, @cross, \$bound\_step, etc.

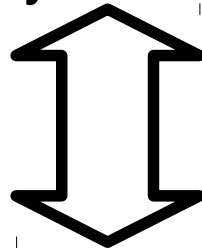
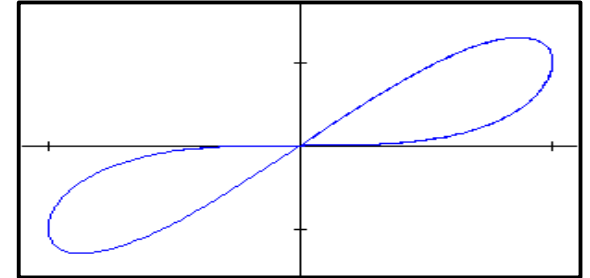
- well-posed

- a solution exists
    - the solution is unique
    - the solution's behavior changes continuously with the initial conditions.



# How to model hysteresis?

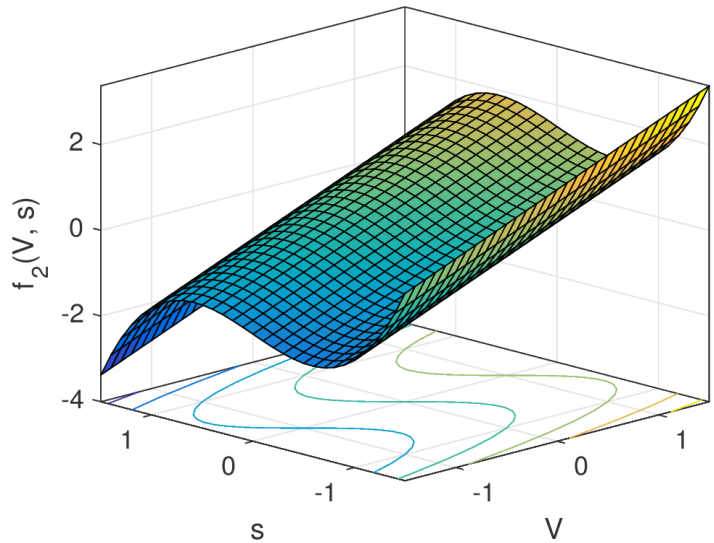
- hysteresis  $\neq$  discontinuity or if-else
- hysteresis  $\neq$  use \$abstime
  - or @(initial\_step), \$bound\_step, etc.
- hysteresis  $\neq$  hybrid models
- hysteresis/multistability  $\neq$  “flat” regions w zero derivatives



- model hysteresis using internal state variable
  - proper design of dynamics
- write internal unknown in Verilog-A
  - use potentials/flows
- set bounds for internal unknown with equations
  - physical distance
  - clipping functions
- smoothness, continuity, finite precision issues, ...



# How to Model Hysteresis Properly

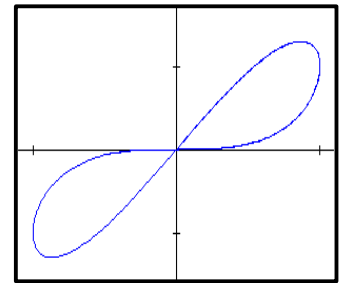
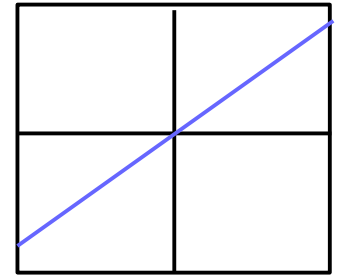


$$\text{ipn} = f(\text{vpn})$$

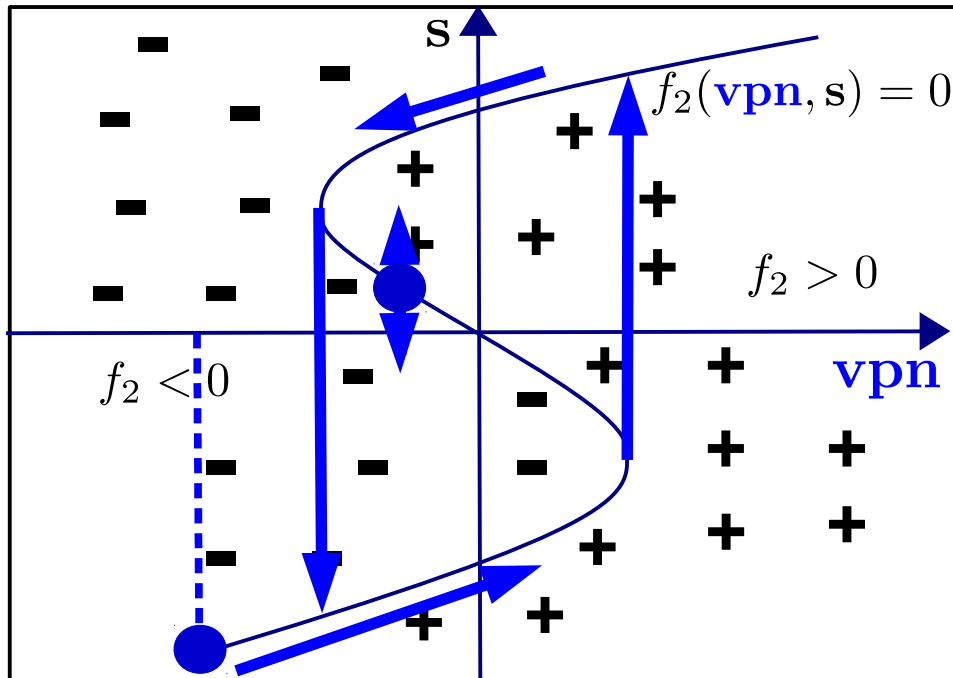


$$\text{ipn} = f_1(\text{vpn}, s)$$

$$\frac{d}{dt}s = f_2(\text{vpn}, s)$$



internal state variable  
"memory"



**Example:**

$$f_1(\text{vpn}, s) = \frac{\text{vpn}}{R} \cdot (1 + \tanh(s))$$

$$f_2(\text{vpn}, s) = \text{vpn} - s^3 + s$$

multistability → abrupt change in DC sols  
negative-sloped fold → hysteresis

# How to Model Hysteresis Properly

**Template:**

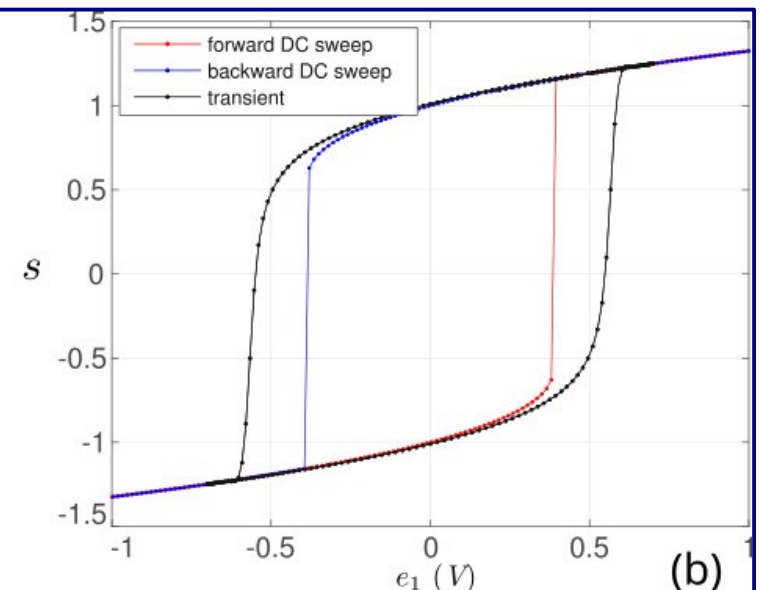
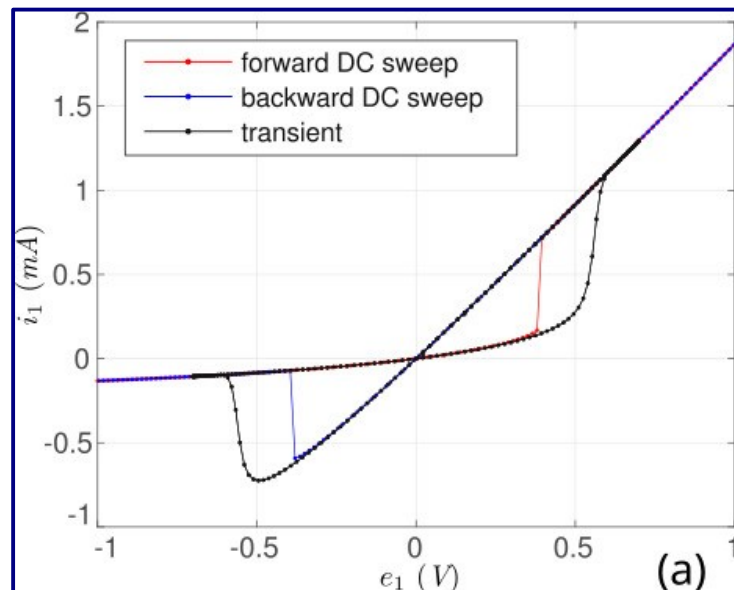
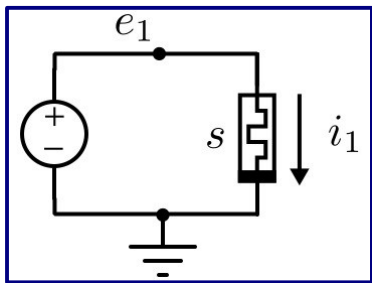
$$i_{pn} = f_1(v_{pn}, s)$$

$$\frac{d}{dt}s = f_2(v_{pn}, s)$$

**MAPP** (our internal simulator):

$$i_{pn} = \frac{d}{dt} \underbrace{q_e(v_{pn}, s)}_{\mathbf{0}} + \underbrace{f_e(v_{pn}, s)}_{f_1}$$

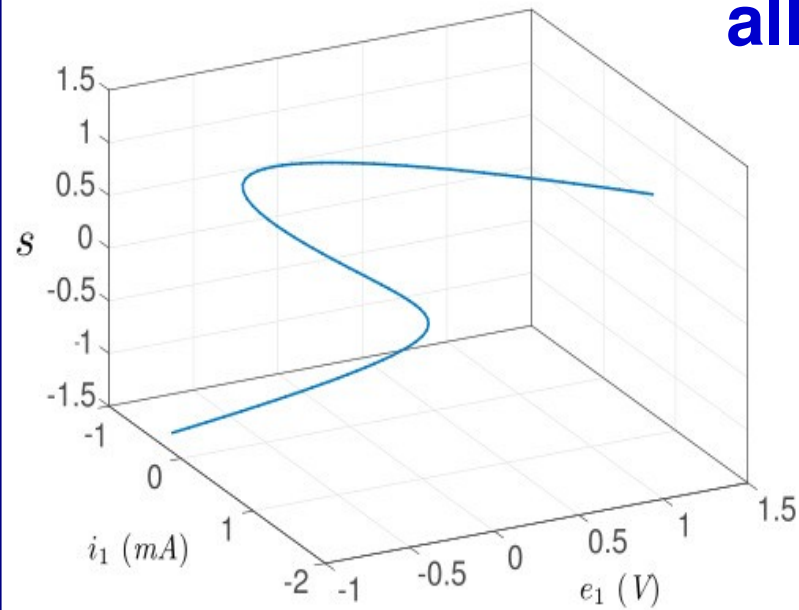
$$0 = \frac{d}{dt} \underbrace{q_i(v_{pn}, s)}_{-s} + \underbrace{f_i(v_{pn}, s)}_{f_2}$$



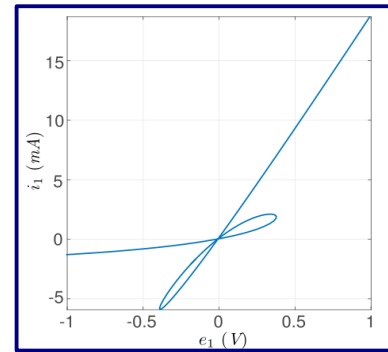


# How to Model Hysteresis Properly

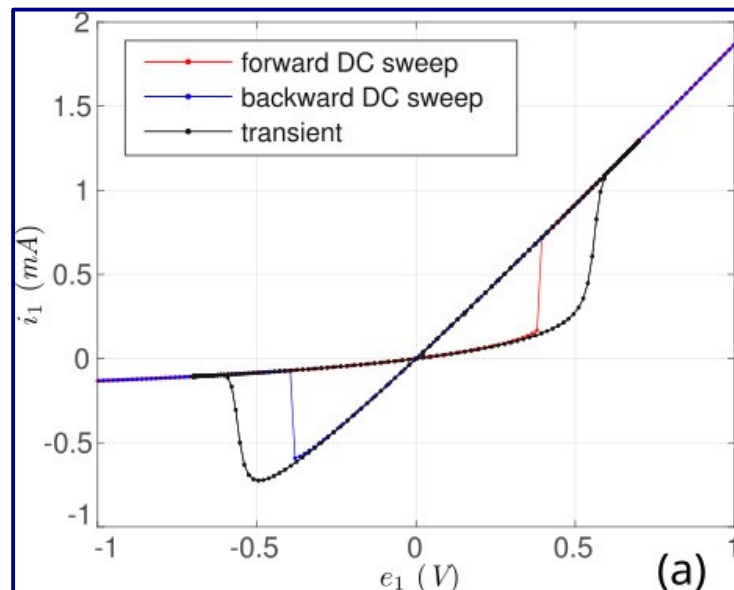
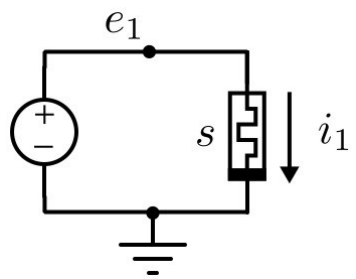
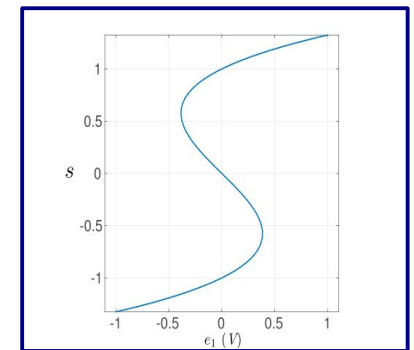
all DC sols from homotopy analysis  
(like a curve tracer)



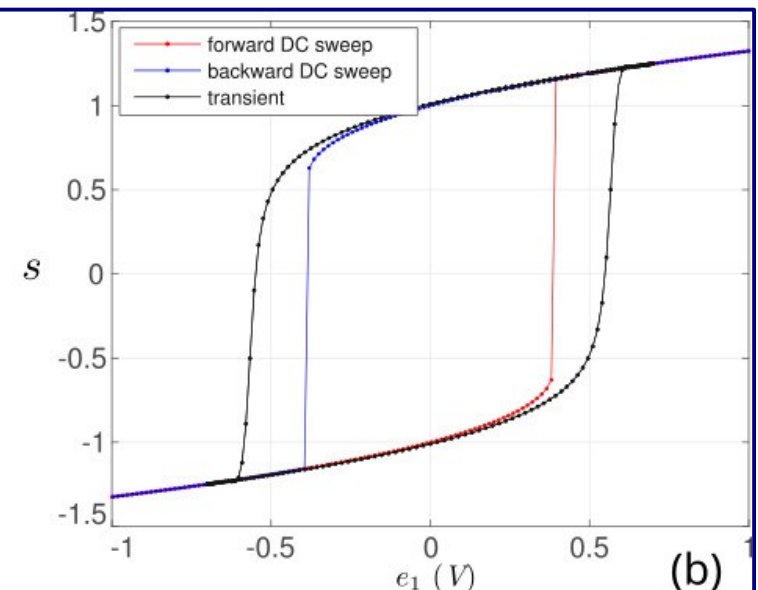
top



side



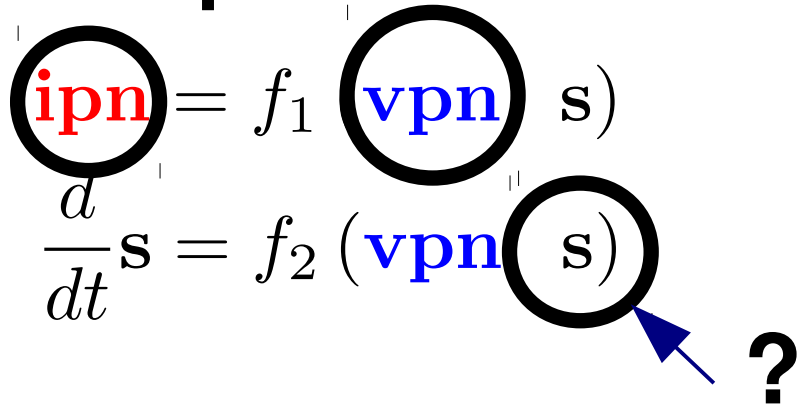
(a)



(b)

# Internal Unknowns in Verilog-A

## Template:

$$\begin{aligned} \text{ipn} &= f_1(\text{vpn}, s) \\ \frac{d}{dt}s &= f_2(\text{vpn}, s) \end{aligned}$$


## Example:

$$f_1(\text{vpn}, s) = \frac{\text{vpn}}{R} \cdot (1 + \tanh(s))$$

$$f_2(\text{vpn}, s) = \text{vpn} - s^3 + s$$

## DO NOT

- declare internal unknowns as "real" variables
- code time integration inside model
  - with \$abstime, @cross, @initial\_step, memory states
- use `idt()`
- use implicit contributions
  - unless you know what you are doing

# Internal Unknowns in Verilog-A

$$ipn = \frac{vpn}{R} \cdot (1 + \tanh(s))$$

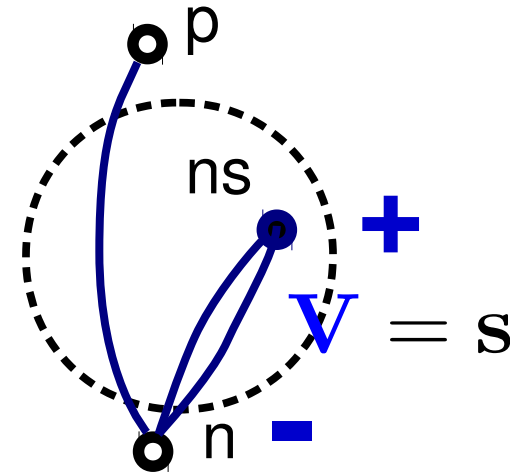
$$\frac{d}{dt}(\tau \cdot s) = vpn - s^3 + s$$

use a potential or flow

```

1 `include "disciplines.vams"
2 module hys(p, n);
3   inout p, n;
4   electrical p, n, ns;
5   branch (ns, n) ns_br1;
6   branch (ns, n) ns_br2;
7   parameter real R = 1e3 from (0:inf);
8   parameter real k = 1 from (0:inf);
9   parameter real tau = 1e-5 from (0:inf);
10  real s;
11
12  analog begin
13    s = V(ns, n);
14    I(p, n) <+ V(p, n)/R * (1+tanh(k*s));
15    I(ns_br1) <+ V(p, n) - pow(s, 3) + s;
16    I(ns_br2) <+ ddt(-tau*s);
17  end
18 endmodule
    
```

internal node

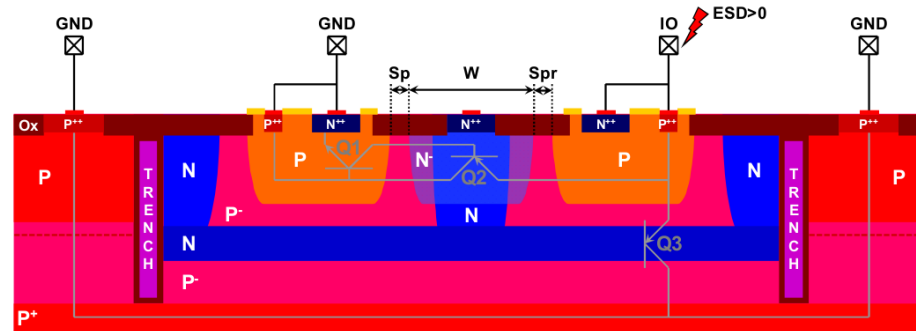


internal unknown

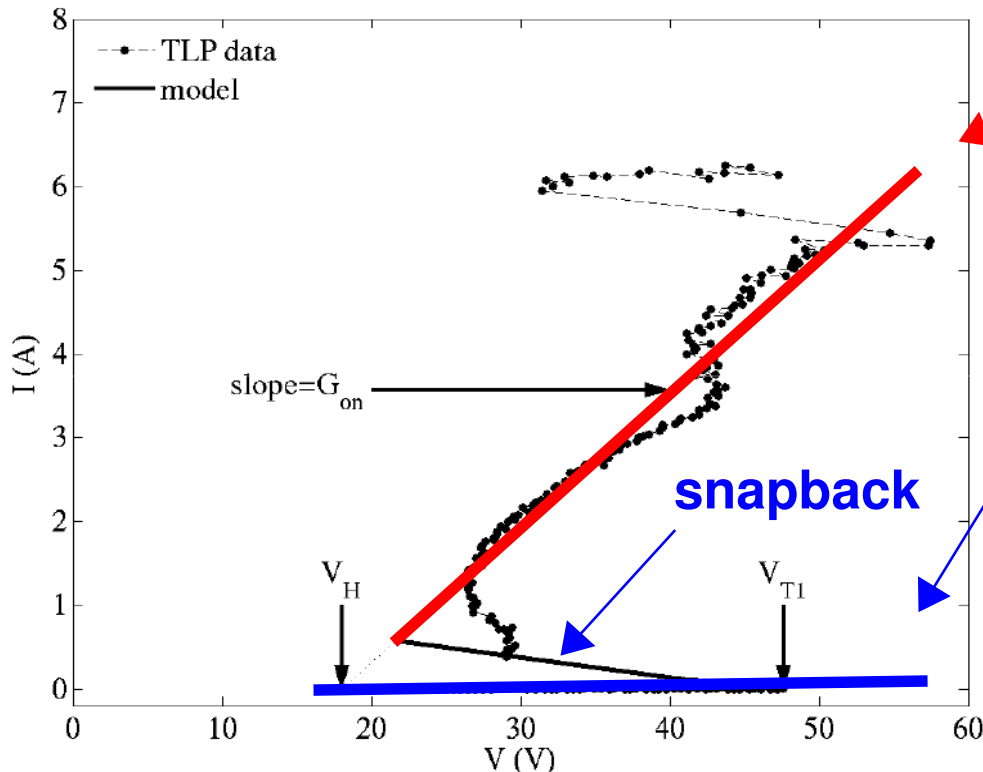
implicit differential equation

# ESD Snapback Model

ESD protection device



Gendron, et al. "New High Voltage ESD Protection Devices based on Bipolar Transistors for Automotive Applications." IEEE EOS/ESD Symposium, 2011.



Ida/McAndrew. "A Physically-based Behavioral Snapback Model." IEEE EOS/ESD Symposium, 2012.

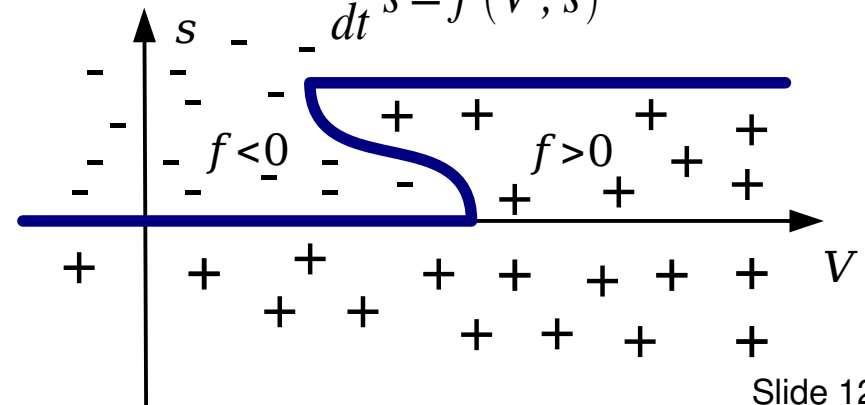
$$I_{on} = G_{on} \cdot (V - V_H)$$

$$I_{off} = I_S \cdot (1 - e^{-V/\phi_T}) \cdot \sqrt{1 + \frac{\max(V, 0)}{V_D}}$$

$$I = s \cdot I_{on} + I_{off}$$

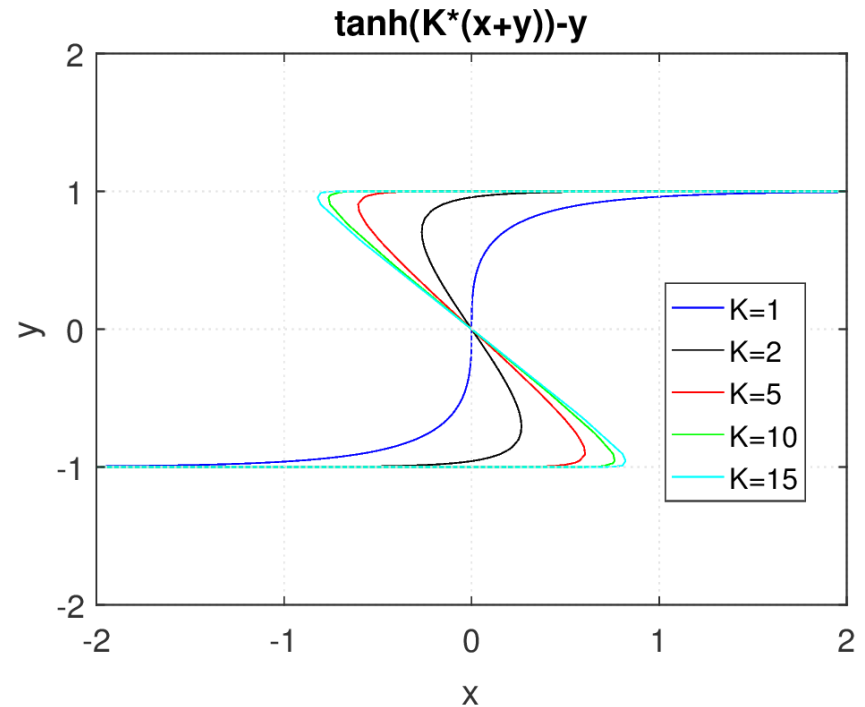
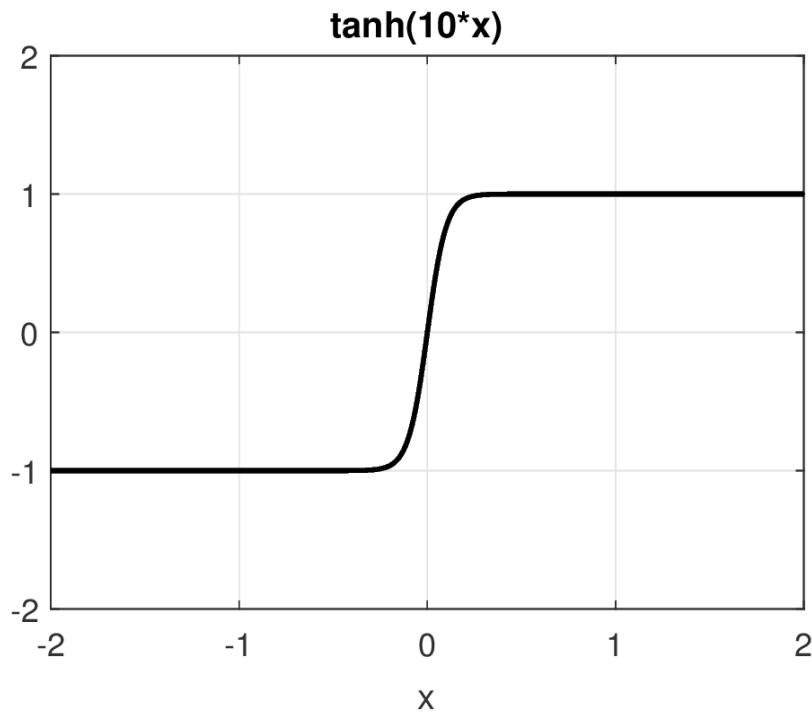
internal state: indicator of impact ionization

$$\frac{d}{dt} s = f(V, s)$$



# ESD Snapback Model

$$\frac{d}{dt}s = f(V, s) \quad \text{many possible functions}$$



```
...  
Vstar = 2*(V(p, n)-0.5*VT1-0.5*VIH)/(VT1-VIH);  
sstar = 2*(s-0.5);  
I(ns, n) <+ tanh(K*(Vstar + sstar)) - sstar;  
...
```

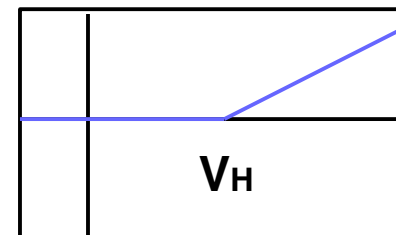
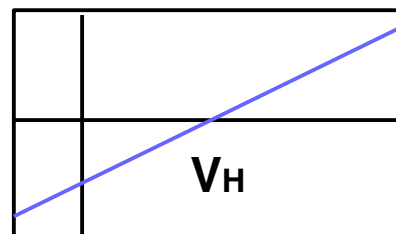
**shift transition points  
shift range to (0, 1)**

# ESD Snapback Model

```
1 `include "disciplines.vams"
2
3 module ESDclamp(p, n);
4     inout p, n;
5     electrical p, n, ns;
6
7     parameter real Gon = 0.1 from (0:inf);
8     ...
9
10    analog begin
11        s = V(ns, n);
12        Ion = smoothclip(Gon*(V(p, n)-VH), smoothing)
13              - smoothclip(-Gon*VH, smoothing);
14        Ioff = Is * (1 - limexp(-V(p, n)/VT))
15                * sqrt(1 + max(V(p, n), 0)/VD);
16        I(p, n) <+ Ioff + pow(s, Alpha) * Ion;
17        I(p, n) <+ ddt(C * V(p, n));
18
19        Vstar = 2*(V(p, n)-0.5*VT1-0.5*VIH)/(VT1-VIH);
20        sstar = 2*(s-0.5);
21        I(ns, n) <+ tanh(K*(Vstar + sstar)) - sstar;
22        I(ns, n) <+ ddt(-tau*s);
23    end
24 endmodule
```

internal unknown  
as a voltage

$I_{on}$



$I_{off}$

implicit  
differential  
equation

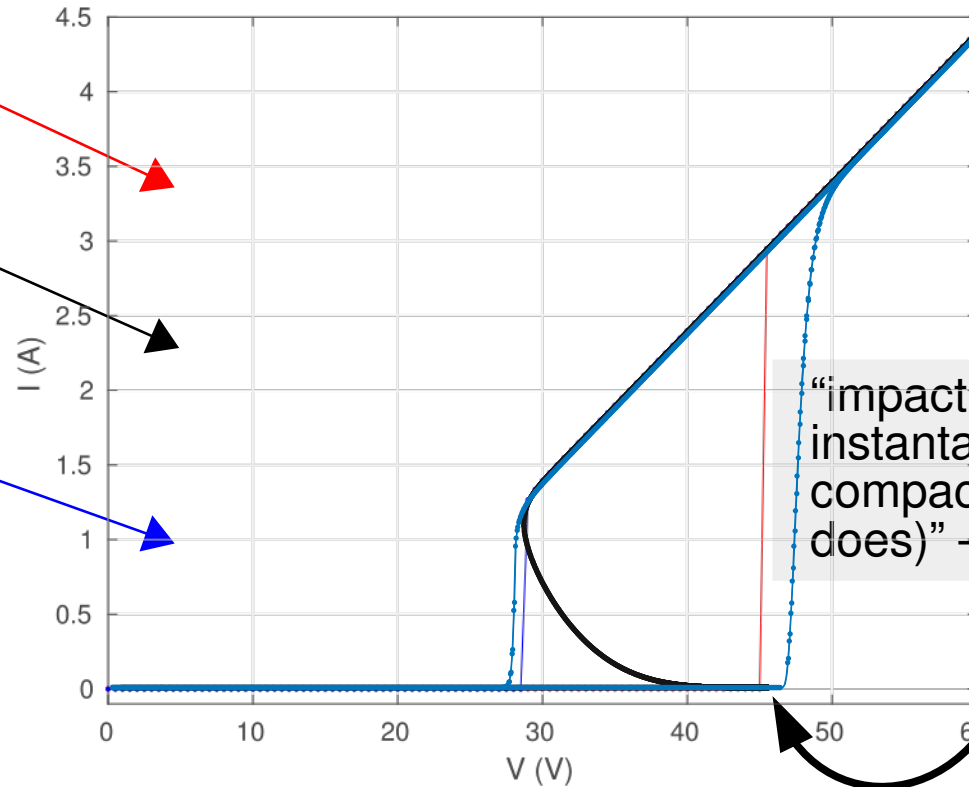


# ESD Snapback Model

forward/backward  
DC sweeps

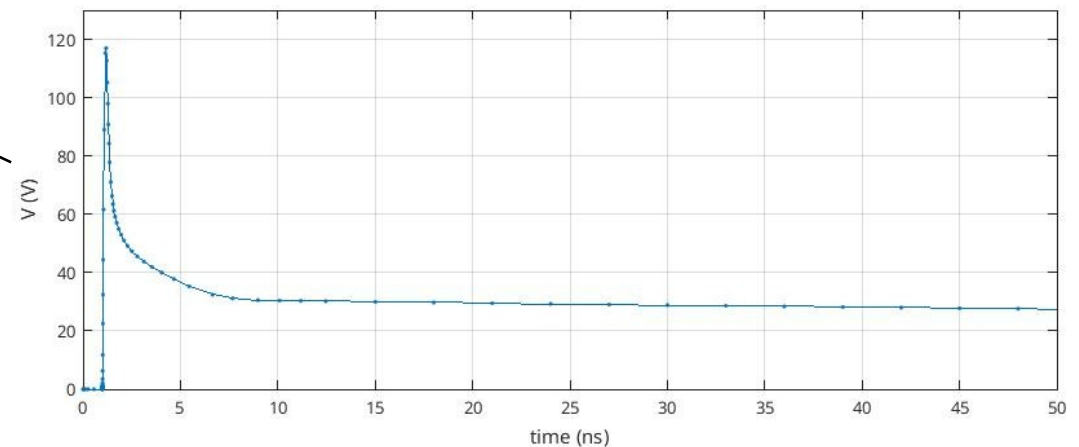
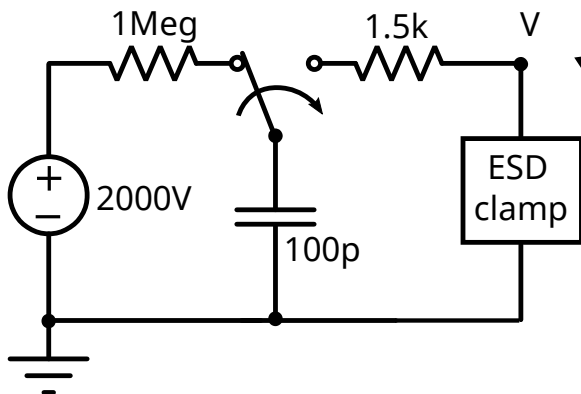
homotopy  
(all DC sols)

transient  
voltage sweeps



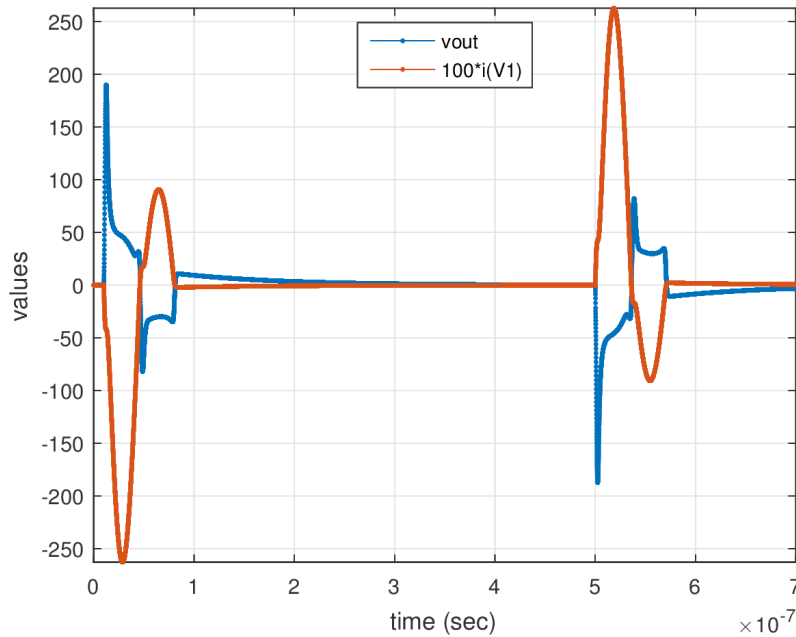
“impact ionization doesn't happen instantaneously (although all compact models assume that it does)” — C.C. McAndrew

Human Body Mode (HBM) test

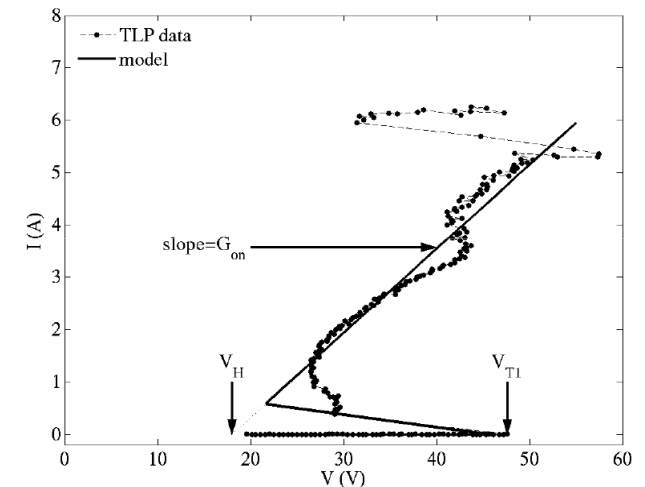
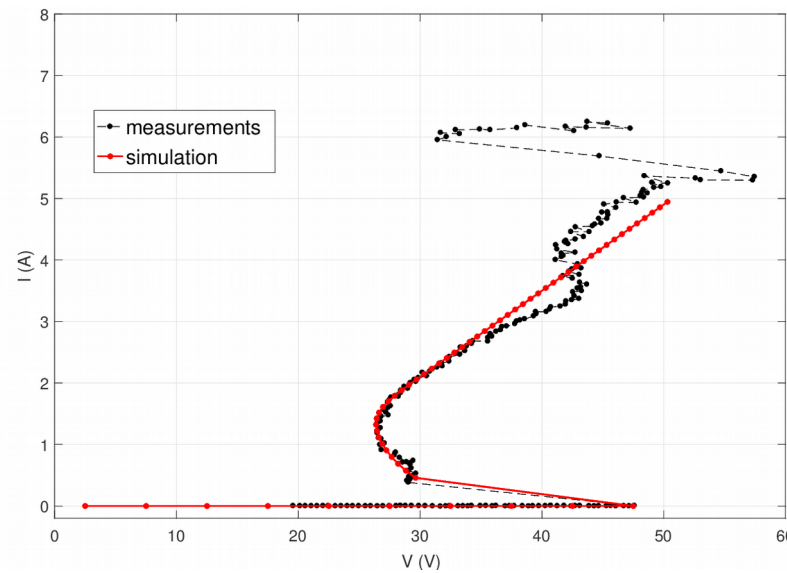
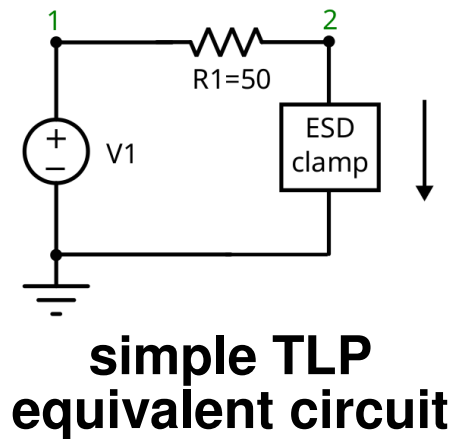
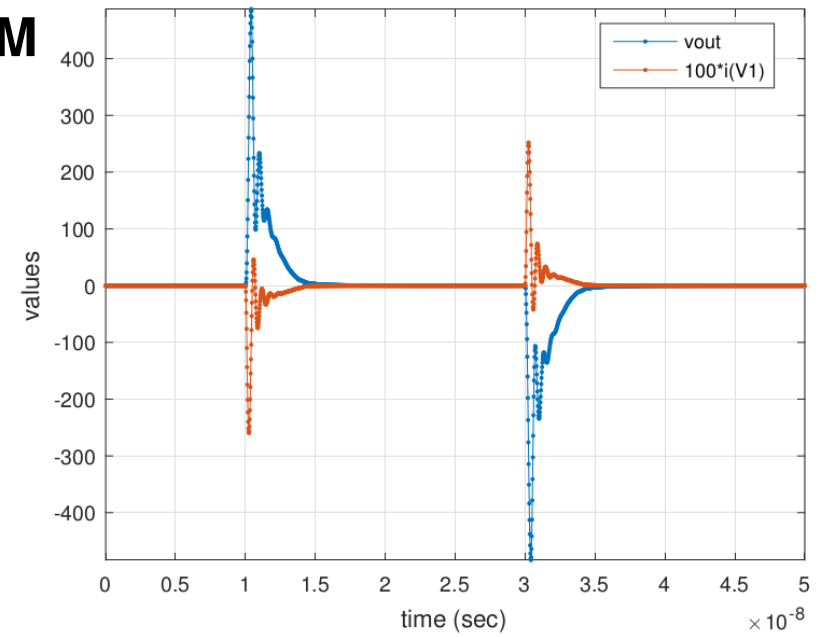


# ESD Snapback Model

**MM**

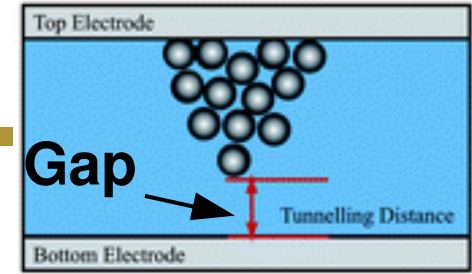


**CDM**



Ida/McAndrew. "A Physically-based Behavioral Snapback Model." IEEE EOS/ESD Symposium, 2012.

# RRAM Model



Template:

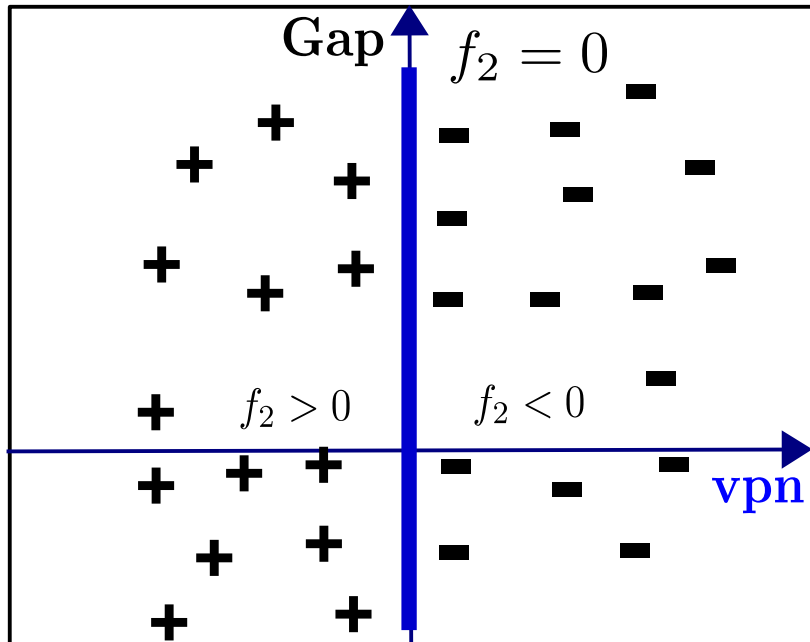
RRAM:

$$ipn = f_1(vpn, s) \quad f_1(vpn, Gap) = I_0 \cdot e^{-Gap/g_0} \cdot \sinh(vpn/V_0)$$

$$\frac{d}{dt}s = f_2(vpn, s) \quad f_2(vpn, Gap) = -v_0 \cdot \exp\left(-\frac{E_a}{V_T}\right) \cdot \sinh\left(\frac{vpn \cdot \gamma \cdot a_0}{t_{ox} \cdot V_T}\right)$$

Jiang, Z., Wong, H. (2014). Stanford University Resistive-Switching Random Access Memory (RRAM) Verilog-A Model. nanoHUB.

$$\minGap \leq Gap \leq \maxGap$$



~~if gap < minGap  
gap = minGap;~~

**hybrid model**

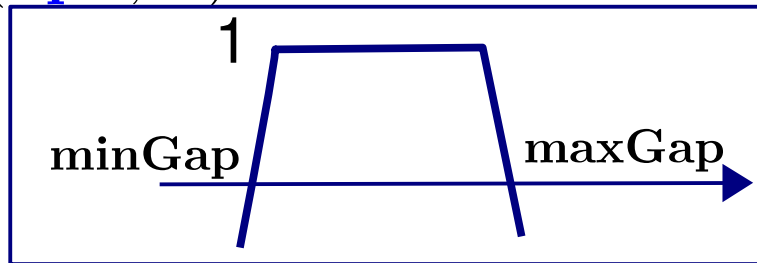
# RRAM Model

Template:

RRAM:

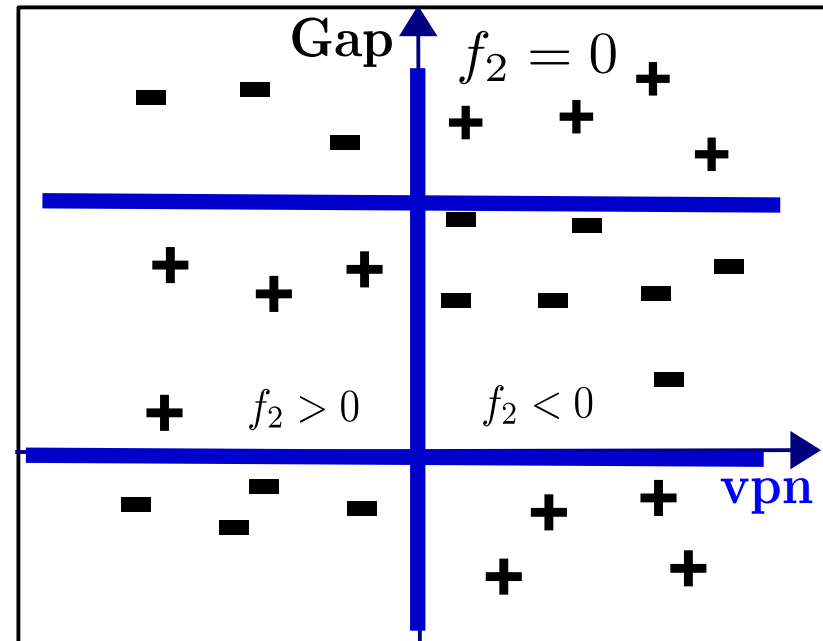
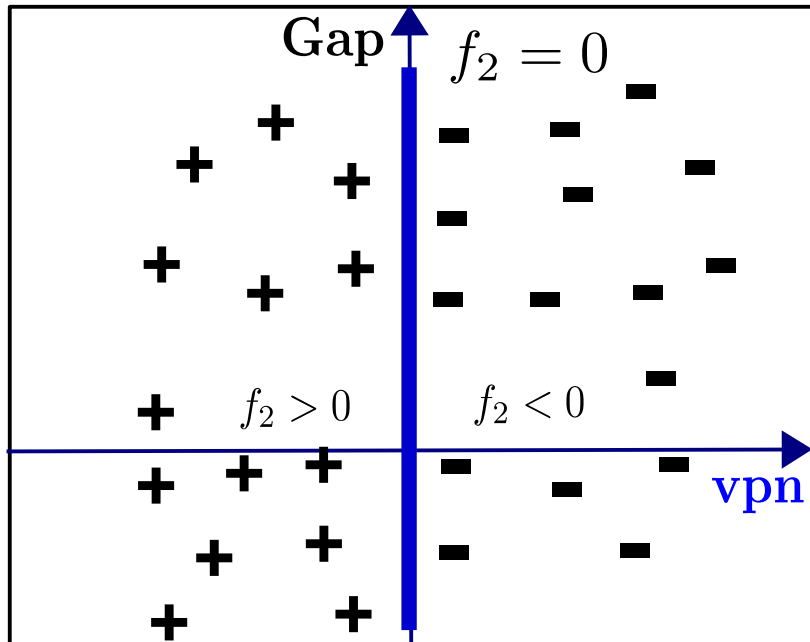
$$ipn = f_1(vpn, s) \quad f_1(vpn, Gap) = I_0 \cdot e^{-Gap/g_0} \cdot \sinh(vpn/V_0)$$

$$\frac{d}{dt}s = f_2(vpn, s) \quad f_2(vpn, Gap) = -v_0 \cdot \exp\left(-\frac{E_a}{V_T}\right) \cdot \sinh\left(\frac{vpn \cdot \gamma \cdot a_0}{t_{ox} \cdot V_T}\right)$$

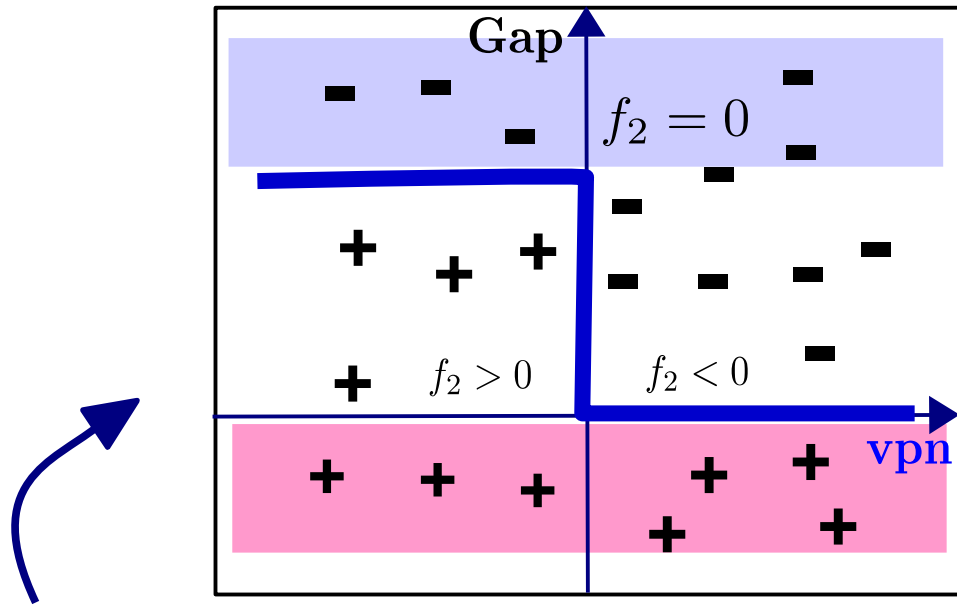


$$\times F_{window}(Gap)$$

Biolek, Jogelkar, Prodromakis, UMich, TEAM/VTEAM, Yakopcic, etc.

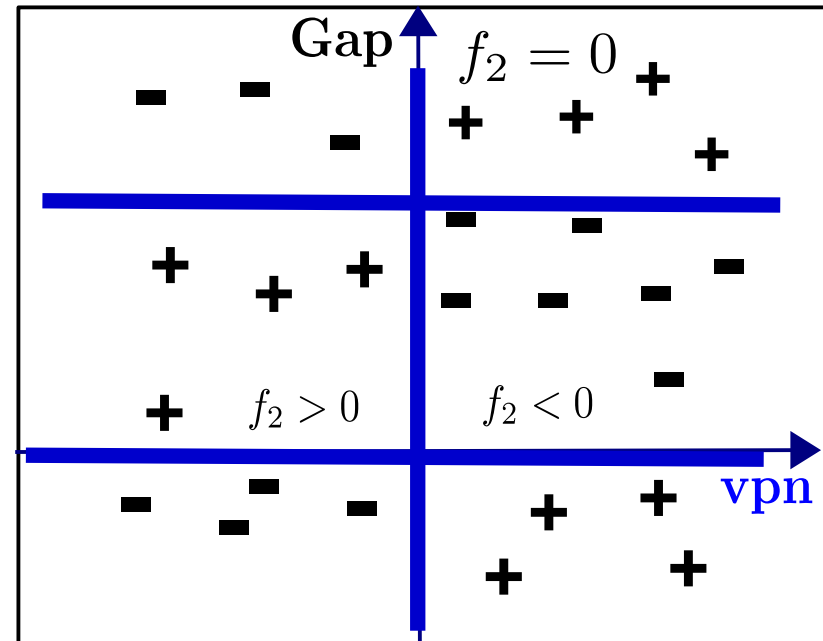
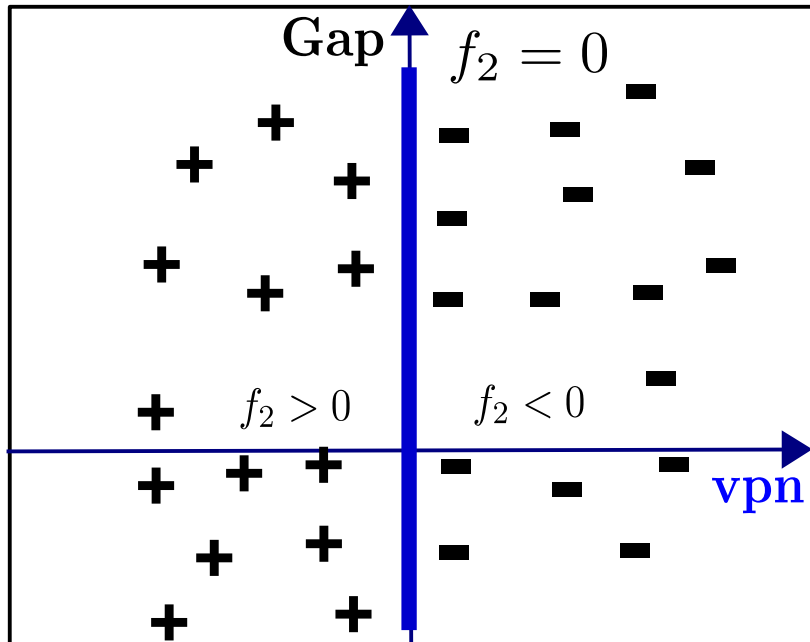


# RRAM Model



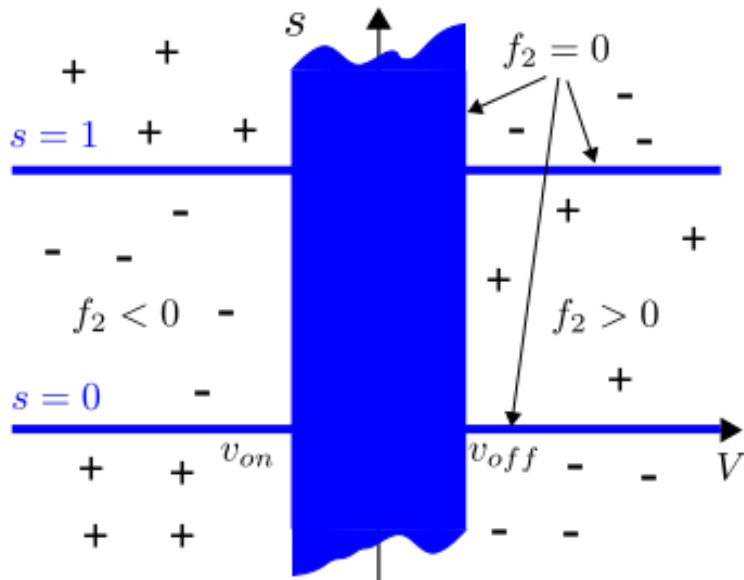
clipping functions

**Analogy:** MEMS switch  
Zener diode voltage regulator

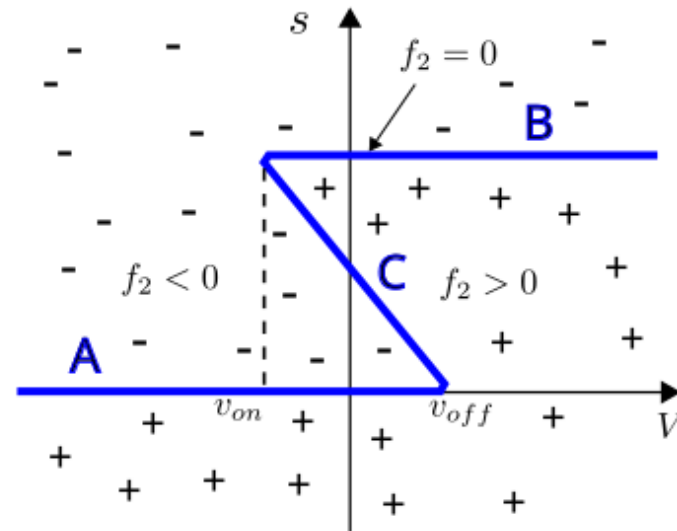


# Memristor Models

## Another (deeper) problem with $f_2$



TEAM/VTEAM, Yakopcic models



fix flat  $f_2$  region

$$f_2 = \begin{cases} k_{off} \cdot \left(\frac{v_{pn}}{v_{off}} - 1\right)^{\alpha_{off}}, & \text{if } v_{pn} > v_{off} \\ k_{on} \cdot \left(\frac{v_{pn}}{v_{on}} - 1\right)^{\alpha_{on}}, & \text{if } v_{pn} < v_{on} \\ 0, & \text{otherwise} \end{cases} \rightarrow f_2 = \begin{cases} k_{off} \cdot \left(\frac{v_{pn} - v^*}{v_{off}}\right)^{\alpha_{off}}, & \text{if } v_{pn} > v^* \\ k_{on} \cdot \left(\frac{v_{pn} - v^*}{v_{on}}\right)^{\alpha_{on}}, & \text{otherwise,} \end{cases}$$

where

$$v^* = (1 - s) \cdot v_{off} + s \cdot v_{on}$$



# Memristor Models

$$\frac{d}{dt}s = f_2(\mathbf{vpn}, s)$$

**Available f<sub>2</sub>:**

① linear ion drift

$$f_2 = \mu_v \cdot R_{on} \cdot f_1(\mathbf{vpn}, s)$$

② nonlinear ion drift

$$f_2 = a \cdot \mathbf{vpn}^m$$

③ Simmons tunnelling barrier

$$f_2 = \begin{cases} c_{off} \cdot \sinh\left(\frac{i}{i_{off}}\right) \cdot \exp\left(-\exp\left(\frac{s-a_{off}}{w_c} - \frac{i}{b}\right) - \frac{s}{w_c}\right), & \text{if } i \geq 0 \\ c_{on} \cdot \sinh\left(\frac{i}{i_{on}}\right) \cdot \exp\left(-\exp\left(\frac{a_{on}-s}{w_c} + \frac{i}{b}\right) - \frac{s}{w_c}\right), & \text{otherwise,} \end{cases}$$

④ TEAM model

⑤ Yakopcic model

⑥ Stanford/ASU

$$f_2 = -v_0 \cdot \exp\left(-\frac{E_a}{V_T}\right) \cdot \sinh\left(\frac{\mathbf{vpn} \cdot \gamma \cdot a_0}{t_{ox} \cdot V_T}\right)$$

$$\mathbf{ipn} = f_1(\mathbf{vpn}, s)$$

**Available f<sub>1</sub>:**

①  $f_1 = (R_{on} \cdot s + R_{off} \cdot (1 - s))^{-1} \cdot \mathbf{vpn}$

②  $f_1 = \frac{1}{R_{on}} \cdot e^{-\lambda \cdot (1-s)} \cdot \mathbf{vpn}$

③  $f_1 = s^n \cdot \beta \cdot \sinh(\alpha \cdot \mathbf{vpn}) + \chi \cdot (\exp(\gamma \cdot) - 1)$

④  $f_1 = \begin{cases} A_1 \cdot s \cdot \sinh(B \cdot \mathbf{vpn}), & \text{if } \mathbf{vpn} \geq 0 \\ A_2 \cdot s \cdot \sinh(B \cdot \mathbf{vpn}), & \text{otherwise.} \end{cases}$

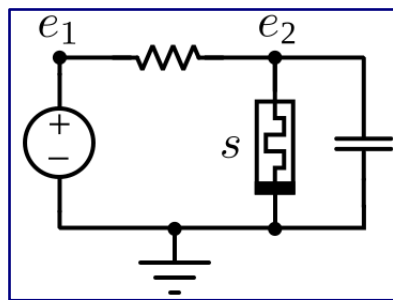
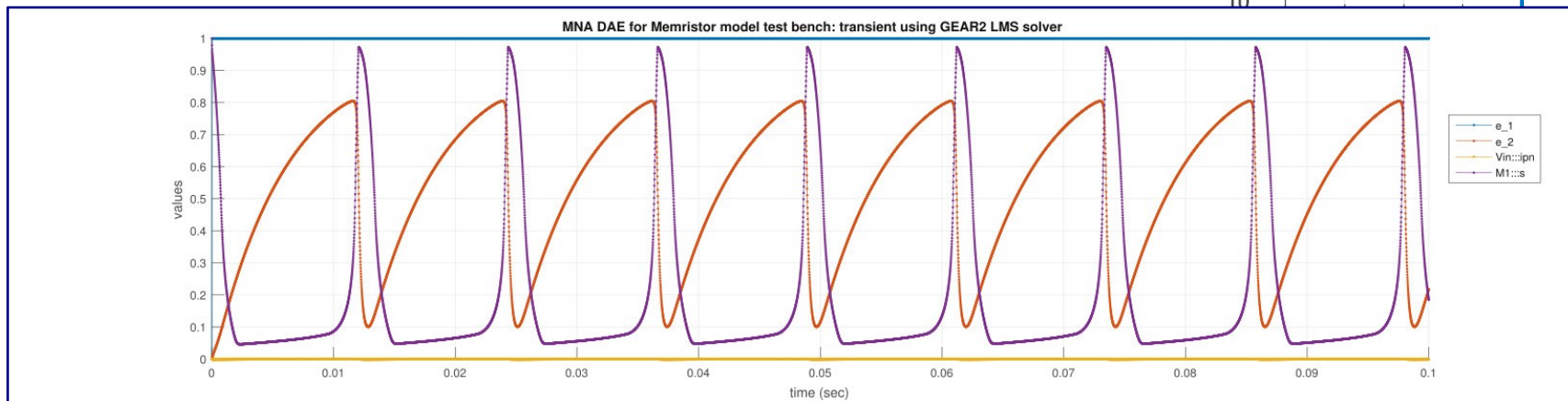
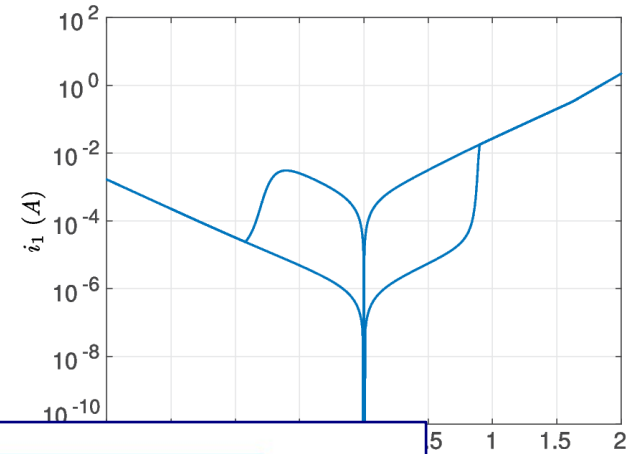
⑤  $f_1 = I_0 \cdot e^{-\text{Gap}/g_0} \cdot \sinh(\mathbf{vpn}/V_0)$   
 $\text{Gap} = s \cdot \text{minGap} + (1 - s) \cdot \text{maxGap}.$

- set up boundary
- fix f<sub>2</sub> flat regions
- smooth, safe funcs, scaling, etc.

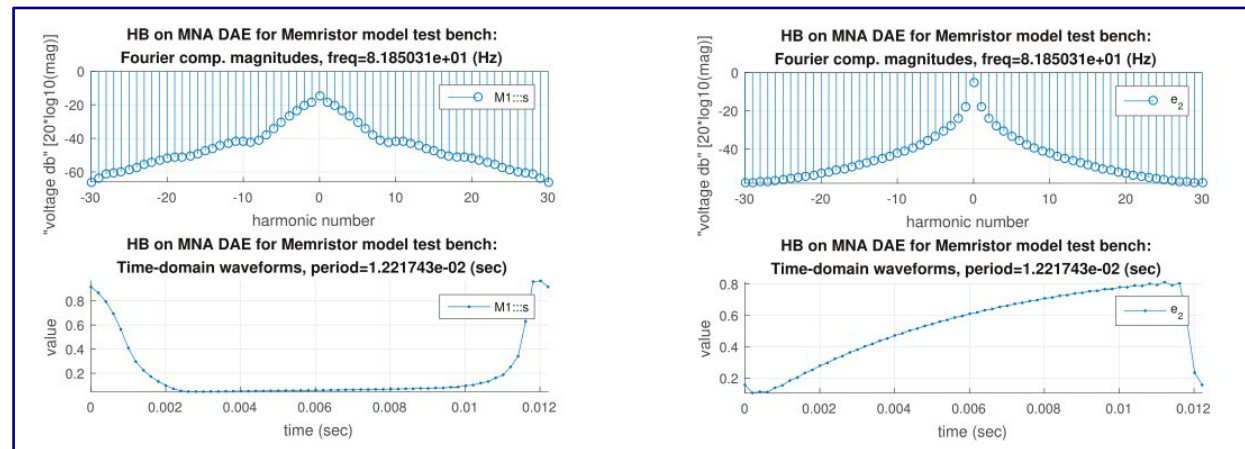
# Memristor Models

## A collection of 30 models:

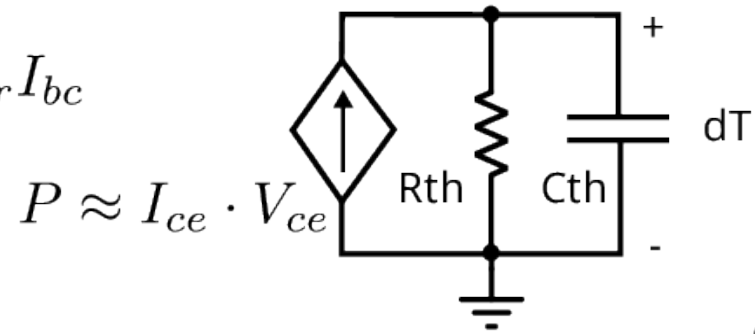
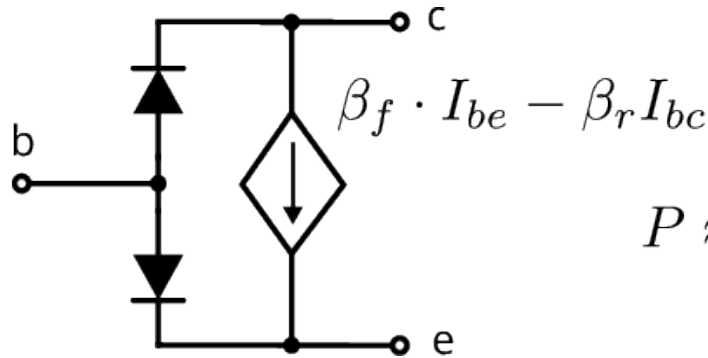
- all smooth, all well posed
- not just RRAM, but general memristive devices
- not just bipolar, but unipolar
- not just DC, AC, TRAN, but homotopy, PSS, ...



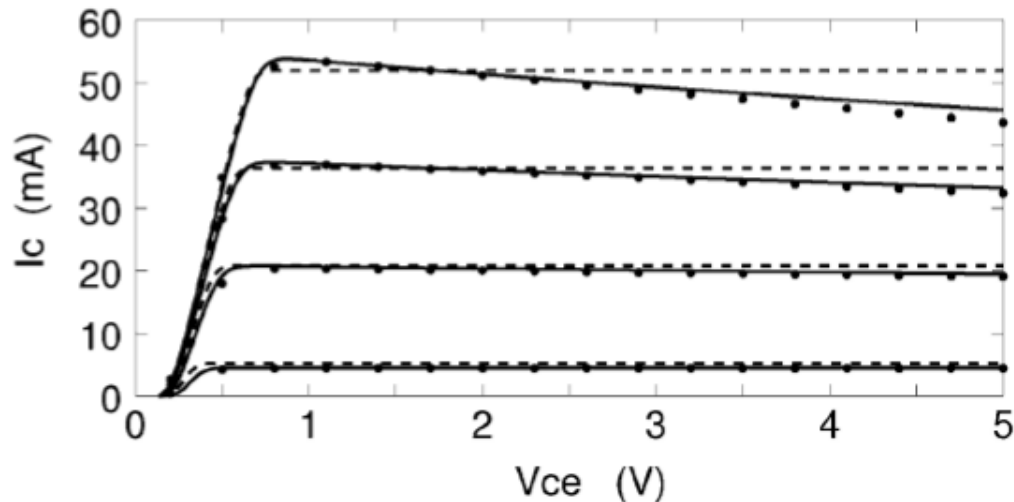
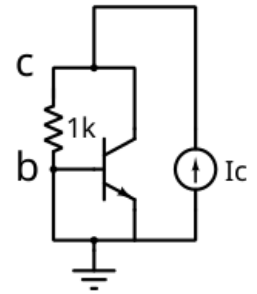
PSS using HB



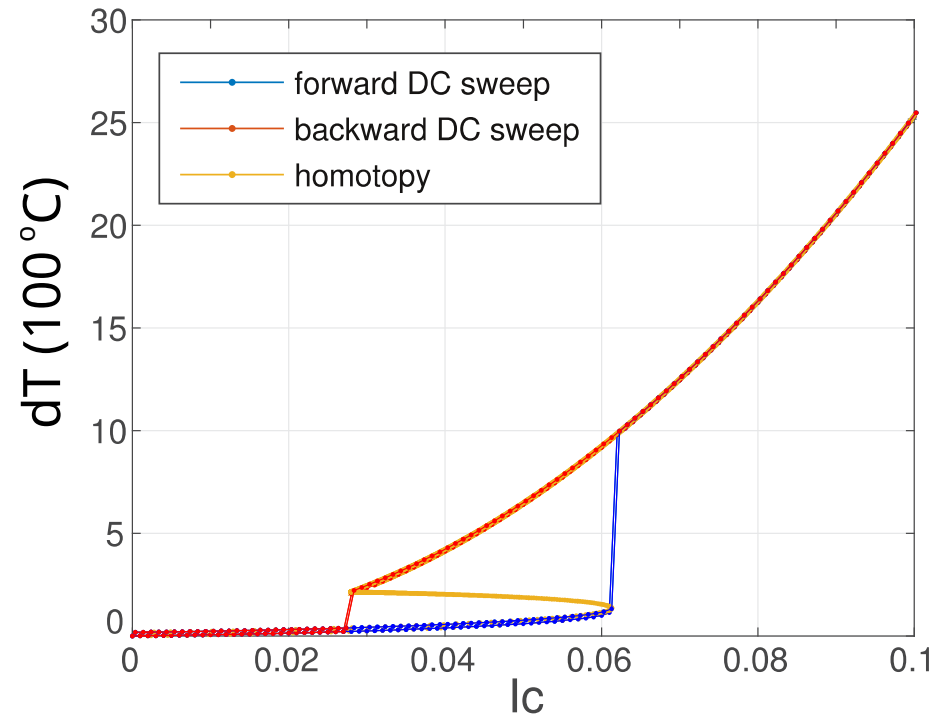
# HBT with Thermal Effects



$$\beta_f = \beta_{f0} - d\beta_f \cdot dT$$

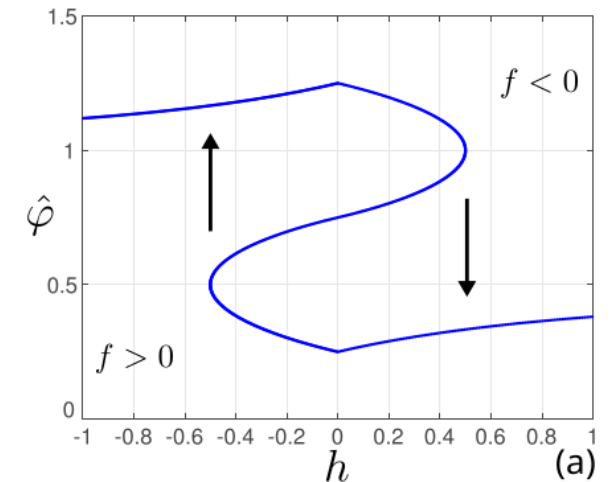
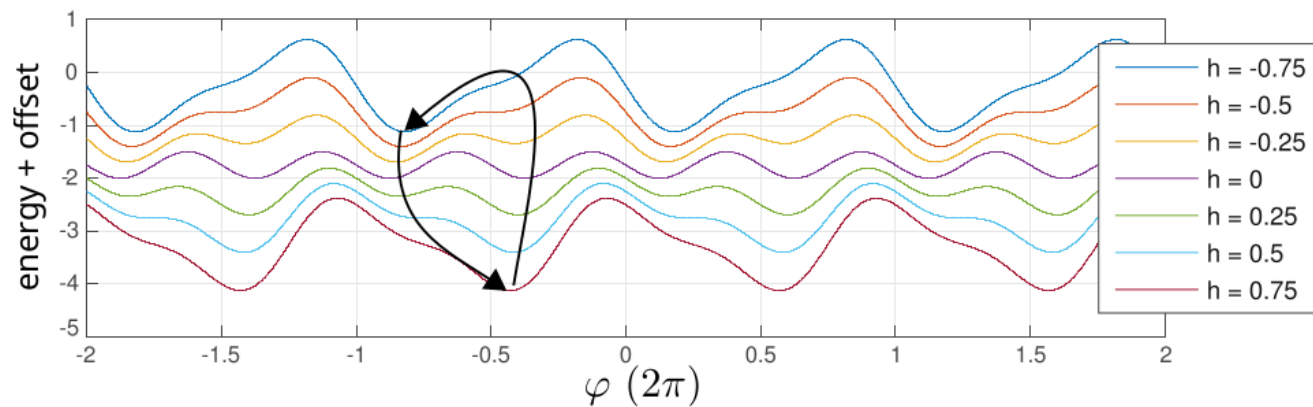
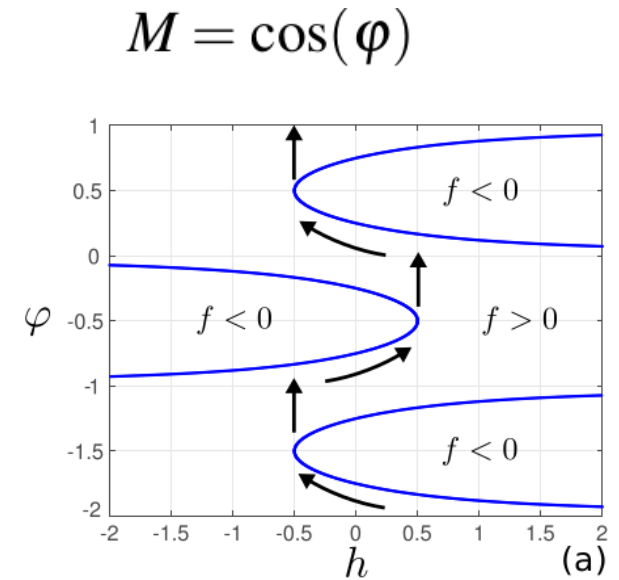
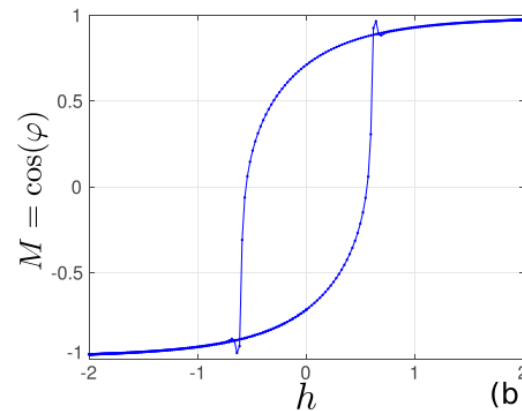
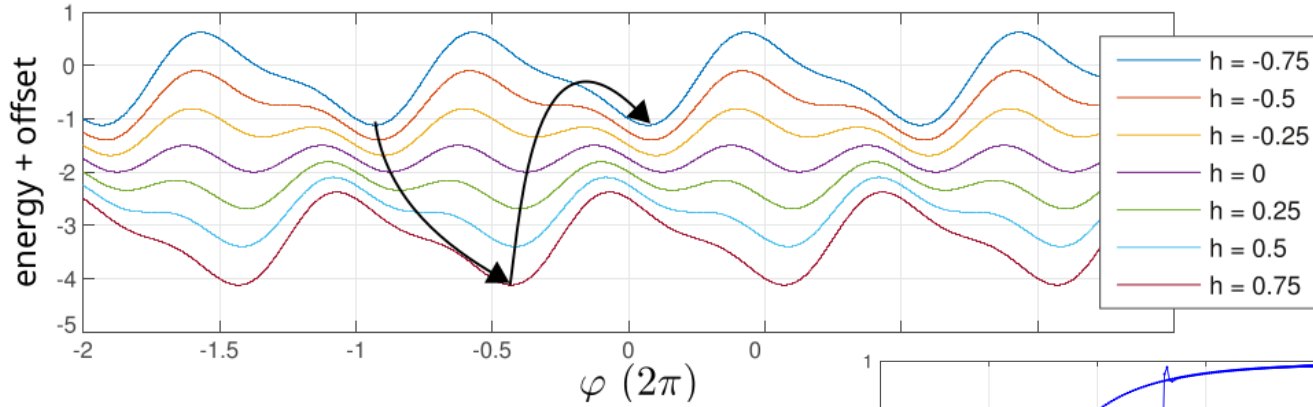


Rudolph "Uniqueness problems in compact HBT models caused by thermal effects." IEEE Trans. MTT 2004



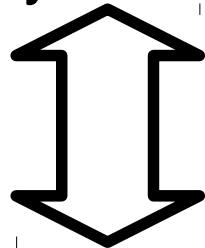
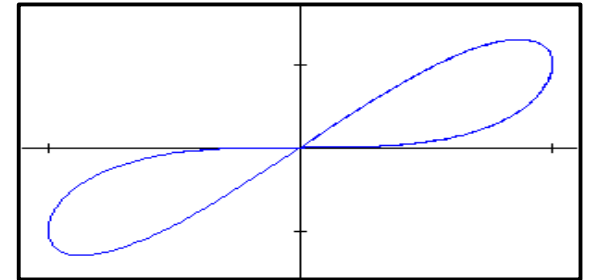
# Ferromagnet Models

Stoner-Wohlfarth Model:  $E(h, \varphi) = \frac{1}{4} - \frac{1}{4} \cos(2(\varphi - \theta)) - h \cos(\varphi)$



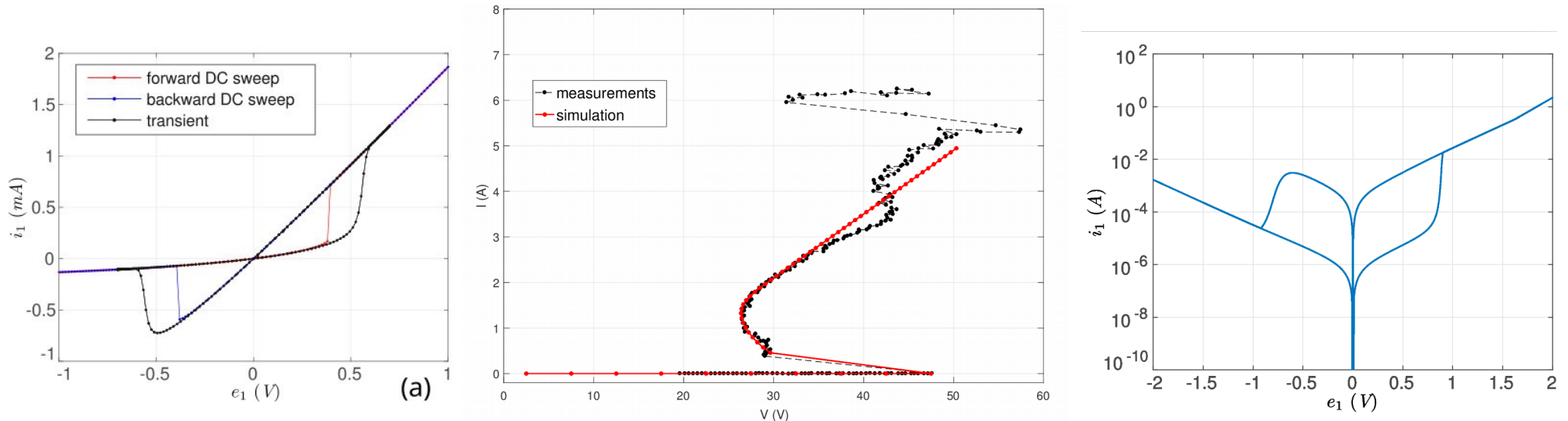
# How to model hysteresis?

- hysteresis  $\neq$  discontinuity or if-else
- hysteresis  $\neq$  use \$abstime
  - or @(initial\_step), \$bound\_step, etc.
- hysteresis  $\neq$  hybrid models
- hysteresis/multistability  $\neq$  “flat” regions w zero derivatives



- model hysteresis using internal state variable
  - proper design of dynamics
- write internal unknown in Verilog-A
  - use potentials/flows
- set bounds for internal unknown with equations
  - physical distance
  - clipping functions
- smoothness, continuity, finite precision issues, ...

# How to model hysteresis?



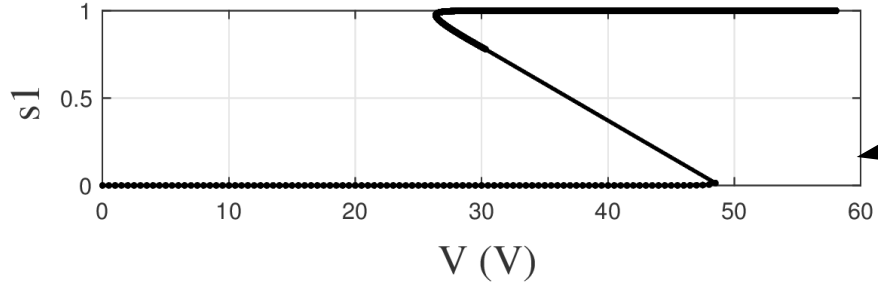
- model hysteresis using internal state variable
  - proper design of dynamics
- write internal unknown in Verilog-A
  - use potentials/flows
- set bounds for internal unknown with equations
  - physical distance
  - clipping functions
- smoothness, continuity, finite precision issues, ...





# Modeling Second Snapback

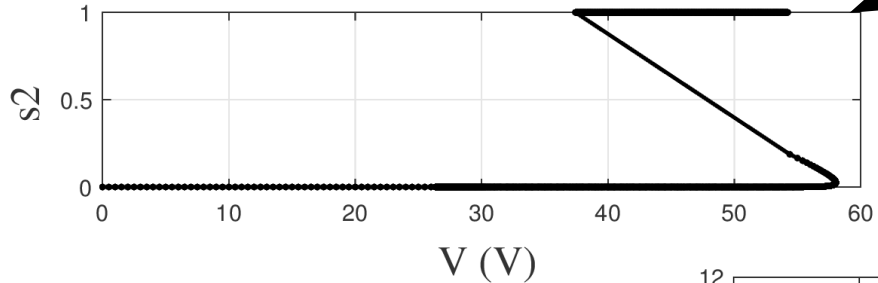
$$d/dt s1 = f(V, s1) = 0$$



$$I = I_{off} + s_1 \cdot I_{on1} + s_2 \cdot I_{on2}$$

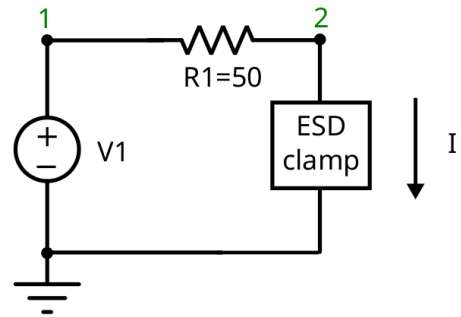
another internal unknown  
different transition voltages

$$d/dt s2 = f(V, s2) = 0$$

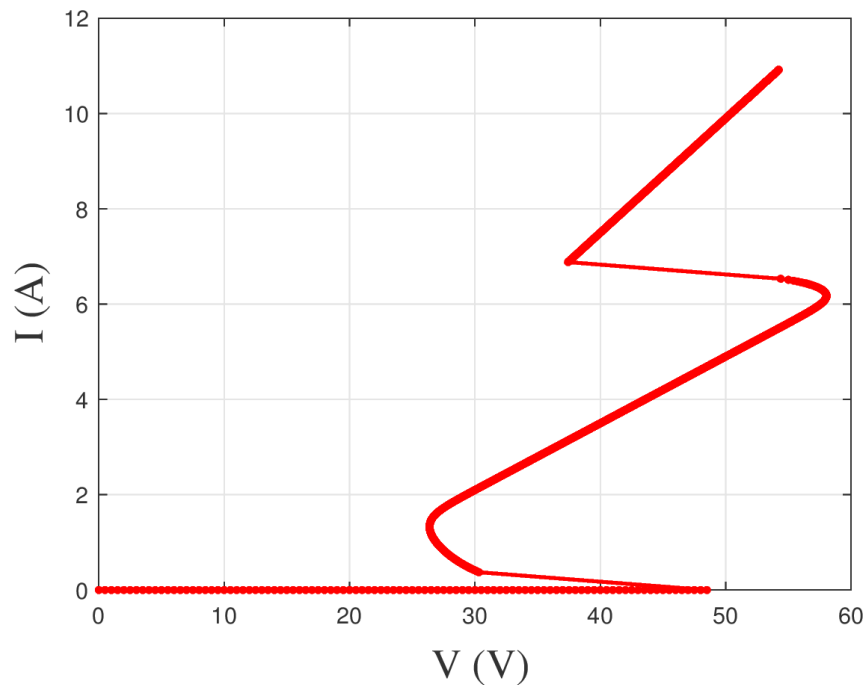


```

...
I(ns2,n) <+ (tanh(K2*(V2star + s2star)) - s2star)
             * smoothstep(s1-0.9, smoothing);
I(ns2,n) <+ ddt(-tau2*s2);
...
    
```



simple TLP  
equivalent circuit



s2 dynamics is on  
only when s1 close to 1

# ESD Snapback Model

